

**Notice of References Cited**

Application/Control No.

10/780,262

Applicant(s)/Patent Under  
Reexamination  
QIU ET AL.

Examiner

Jianye Wu

Art Unit

2616

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0059792 A1	03-2003	Palsson et al.	435/6
*	B	US-2003/0099194 A1	05-2003	Lee et al.	370/229
*	C	US-2003/0227924 A1	12-2003	Kodialam et al.	370/395.21
*	D	US-6,771,966 B1	08-2004	Chow, Peter El Kwan	455/446
*	E	US-2004/0250128 A1	12-2004	Bush et al.	713/201
*	F	US-2004/0267395 A1	12-2004	Discenzo et al.	700/099
*	G	US-2005/0010675 A1	01-2005	Jaggi et al.	709/232
*	H	US-2005/0078610 A1	04-2005	Previdi et al.	370/254
*	I	US-2005/0180329 A1	08-2005	Qiu et al.	370/238
*	J	US-7,130,789 B2	10-2006	Glodjo et al.	705/37
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.